VERIFICATION OF CONFORMITY

Registration No.	:	**WTX26X04114894**
Reference No.	:	**WTX26X04114894E**
Applicant	:	**Shenzhen Fashion Star Technology Co., Ltd.**
Address	:	**6B, Building B3 (Passenger Elevator, Unit A), China Merchants Guangming Science & Technology Park, Fenghuang Street, Guangming District, Shenzhen City**
Manufacturer	:	**Shenzhen Fashion Star Technology Co., Ltd.**
Address	:	**6B, Building B3 (Passenger Elevator, Unit A), China Merchants Guangming Science & Technology Park, Fenghuang Street, Guangming District, Shenzhen City**
Product Name	:	**Servo**
Trade Name	:	**FashionStar**
Model(s)	:	**Star Arm 102-LD-01, Star Arm 102-LD-02, Star Arm 102-LD-03**
Ratings	:	**Refer to the test report**

Test Standards:

47 CFR FCC Part 15, Subpart B

The above product has been tested by us with the listed standard and found in compliance with the Code of Federal Regulations, Title 47-Telecommunications, FCC Rules and Regulations Part 15, Subpart B and the measurement procedure according to ANSI C63.4:2014 and ANSI C63.4a-2017. The label must be complying with the (a) of the Section 15.19 labelling requirements.

Supplementary Information:

The product herewith has been successfully tested according to the Code of Federal Regulations, Title 47-Telecommunications. Test samples were in an engineering configuration. FCC Conformity Letter of Authorization for marketing will be required based on the final product when needed. Specific test configurations and results are published by Waltek Testing Group (Shenzhen) Co., Ltd.

Jandy So / GM
Date: 2026-06-23

The statement is based on a single evaluation of the sample of above mentioned product(s). It does not imply an assessment of the whole production.

Waltek Testing Group (Shenzhen) Co., Ltd.
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Ver.02. 08.10.2024, WALTEK is registered trademark. Utilisation and application requires prior approval.